

Reference Numeral List

10 semiconductor wafer
12 region carrying information
14 magnetic means, information for identification
16 magnetic ions
18 magnetic films, magnetic means
20 EPI encapsulation
22 oxide back seal
24 wafer edge
26 magnetic sensor
28 wafer surface
30 wafer surface
110 semiconductor wafer
200 laser scribe beam
210 laser scribe pits
212 contamination
214 contamination
216 contamination

000304-000204